

# STARPOWER

SEMICONDUCTOR

**IGBT**

## GD225MJS120L6S

**1200V/225A 3-level in one-package**

### General Description

STARPOWER IGBT Power Module provides ultra low conduction loss. They are designed for the applications such as 3-level-application.

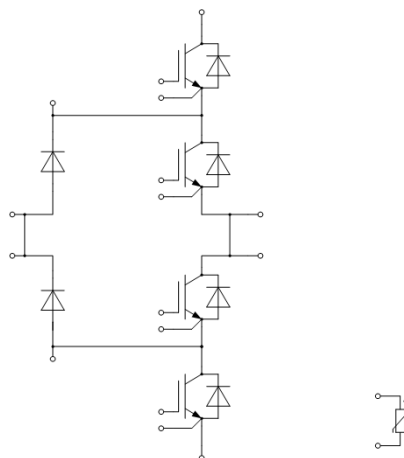
### Features

- Low  $V_{CE(sat)}$  Trench IGBT technology
- $V_{CE(sat)}$  with positive temperature coefficient
- Maximum junction temperature 175 °C
- Fast & soft reverse recovery anti-parallel FWD
- Isolated copper baseplate using DBC technology

### Typical Applications

- Solar power
- 3-level-application

### Equivalent Circuit Schematic



**Absolute Maximum Ratings**  $T_C=25^{\circ}\text{C}$  unless otherwise noted**T1/T4 IGBT**

Symbol	Description	Value	Unit
$V_{CES}$	Collector-Emitter Voltage	1200	V
$V_{GES}$	Gate-Emitter Voltage	$\pm 20$	V
$I_{CN}$	Implemented Collector Current	225	A
$I_C$	Collector Current @ $T_C=100^{\circ}\text{C}$	112	A
$I_{CRM}$	Repetitive Peak Collector Current tp limited by $T_{vjop}$	450	A

**T2/T3 IGBT**

Symbol	Description	Value	Unit
$V_{CES}$	Collector-Emitter Voltage	1200	V
$V_{GES}$	Gate-Emitter Voltage	$\pm 20$	V
$I_{CN}$	Implemented Collector Current	225	A
$I_C$	Collector Current @ $T_C=100^{\circ}\text{C}$	112	A
$I_{CRM}$	Repetitive Peak Collector Current tp limited by $T_{vjop}$	450	A

**D1/D4 Diode**

Symbol	Description	Value	Unit
$V_{RRM}$	Repetitive Peak Reverse Voltage	1200	V
$I_{FN}$	Implemented Forward Current	300	A
$I_F$	Diode Continuous Forward Current @ $T_C=100^{\circ}\text{C}$	130	A
$I_{FRM}$	Repetitive Peak Forward Current tp limited by $T_{vjop}$	600	A

**D2/D3 Diode**

Symbol	Description	Value	Unit
$V_{RRM}$	Repetitive Peak Reverse Voltage	1200	V
$I_{FN}$	Implemented Forward Current	225	A
$I_F$	Diode Continuous Forward Current @ $T_C=100^{\circ}\text{C}$	115	A
$I_{FRM}$	Repetitive Peak Forward Current tp limited by $T_{vjop}$	450	A

**D5/D6 Diode**

Symbol	Description	Value	Unit
$V_{RRM}$	Repetitive Peak Reverse Voltage	1200	V
$I_{FN}$	Implemented Forward Current	300	A
$I_F$	Diode Continuous Forward Current @ $T_C=100^{\circ}\text{C}$	130	A
$I_{FRM}$	Repetitive Peak Forward Current tp limited by $T_{vjop}$	600	A

**Module**

Symbol	Description	Value	Unit
$T_{vjmax}$	Maximum Junction Temperature	175	$^{\circ}\text{C}$
$T_{vjop}$	Operating Junction Temperature	-40 to +150	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature Range	-40 to +125	$^{\circ}\text{C}$
$V_{ISO}$	Isolation Voltage RMS, $f=50\text{Hz}$ , $t=1\text{min}$	3200	V

**T1/T4 IGBT Characteristics**  $T_C=25^{\circ}\text{C}$  unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit	
$V_{CE(sat)}$	Collector to Emitter Saturation Voltage	$I_C=225\text{A}, V_{GE}=15\text{V}, T_{vj}=25^{\circ}\text{C}$		2.00	2.45	V	
		$I_C=225\text{A}, V_{GE}=15\text{V}, T_{vj}=125^{\circ}\text{C}$		2.70			
		$I_C=225\text{A}, V_{GE}=15\text{V}, T_{vj}=150^{\circ}\text{C}$		2.90			
$V_{GE(th)}$	Gate-Emitter Threshold Voltage	$I_C=9.00\text{mA}, V_{CE}=V_{GE}, T_{vj}=25^{\circ}\text{C}$	5.6	6.2	6.8	V	
$I_{CES}$	Collector Cut-Off Current	$V_{CE}=V_{CES}, V_{GE}=0\text{V}, T_{vj}=25^{\circ}\text{C}$			1.0	mA	
$I_{GES}$	Gate-Emitter Leakage Current	$V_{GE}=V_{GES}, V_{CE}=0\text{V}, T_{vj}=25^{\circ}\text{C}$			400	nA	
$R_{Gint}$	Internal Gate Resistance			1.7		$\Omega$	
$C_{ies}$	Input Capacitance	$V_{CE}=25\text{V}, f=100\text{kHz}, V_{GE}=0\text{V}$		38.1		nF	
$C_{res}$	Reverse Transfer Capacitance				0.66		nF
$Q_G$	Gate Charge	$V_{GE}=-15\dots+15\text{V}$		2.52		$\mu\text{C}$	
$t_{d(on)}$	Turn-On Delay Time	$V_{CC}=600\text{V}, I_C=225\text{A}, R_G=2.0\Omega, L_S=20\text{nH}, V_{GE}=-8/+15\text{V}, T_{vj}=25^{\circ}\text{C}$		154		ns	
$t_r$	Rise Time			45		ns	
$t_{d(off)}$	Turn-Off Delay Time			340		ns	
$t_f$	Fall Time			76		ns	
$E_{on}$	Turn-On Switching Loss			13.4		mJ	
$E_{off}$	Turn-Off Switching Loss			8.08		mJ	
$t_{d(on)}$	Turn-On Delay Time		$V_{CC}=600\text{V}, I_C=225\text{A}, R_G=2.0\Omega, L_S=20\text{nH}, V_{GE}=-8/+15\text{V}, T_{vj}=125^{\circ}\text{C}$		160		ns
$t_r$	Rise Time				49		ns
$t_{d(off)}$	Turn-Off Delay Time				388		ns
$t_f$	Fall Time				112		ns
$E_{on}$	Turn-On Switching Loss			17.6		mJ	
$E_{off}$	Turn-Off Switching Loss			11.2		mJ	
$t_{d(on)}$	Turn-On Delay Time	$V_{CC}=600\text{V}, I_C=225\text{A}, R_G=2.0\Omega, L_S=20\text{nH}, V_{GE}=-8/+15\text{V}, T_{vj}=150^{\circ}\text{C}$			163		ns
$t_r$	Rise Time				51		ns
$t_{d(off)}$	Turn-Off Delay Time			397		ns	
$t_f$	Fall Time			114		ns	
$E_{on}$	Turn-On Switching Loss			18.7		mJ	
$E_{off}$	Turn-Off Switching Loss			12.0		mJ	

**T2/T3 IGBT Characteristics**  $T_C=25^\circ\text{C}$  unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit	
$V_{CE(sat)}$	Collector to Emitter Saturation Voltage	$I_C=225\text{A}, V_{GE}=15\text{V}, T_{vj}=25^\circ\text{C}$		2.00	2.45	V	
		$I_C=225\text{A}, V_{GE}=15\text{V}, T_{vj}=125^\circ\text{C}$		2.70			
		$I_C=225\text{A}, V_{GE}=15\text{V}, T_{vj}=150^\circ\text{C}$		2.90			
$V_{GE(th)}$	Gate-Emitter Threshold Voltage	$I_C=9.00\text{mA}, V_{CE}=V_{GE}, T_{vj}=25^\circ\text{C}$	5.6	6.2	6.8	V	
$I_{CES}$	Collector Cut-Off Current	$V_{CE}=V_{CES}, V_{GE}=0\text{V}, T_{vj}=25^\circ\text{C}$			1.0	mA	
$I_{GES}$	Gate-Emitter Leakage Current	$V_{GE}=V_{GES}, V_{CE}=0\text{V}, T_{vj}=25^\circ\text{C}$			400	nA	
$R_{Gint}$	Internal Gate Resistance			1.7		$\Omega$	
$C_{ies}$	Input Capacitance	$V_{CE}=25\text{V}, f=100\text{kHz}, V_{GE}=0\text{V}$		38.1		nF	
$C_{res}$	Reverse Transfer Capacitance				0.66		nF
$Q_G$	Gate Charge	$V_{GE}=-15\dots+15\text{V}$		2.52		$\mu\text{C}$	
$t_{d(on)}$	Turn-On Delay Time	$V_{CC}=600\text{V}, I_C=225\text{A}, R_G=2.0\Omega, L_S=20\text{nH}, V_{GE}=-8/+15\text{V}, T_{vj}=25^\circ\text{C}$		153		ns	
$t_r$	Rise Time			46		ns	
$t_{d(off)}$	Turn-Off Delay Time			280		ns	
$t_f$	Fall Time			145		ns	
$E_{on}$	Turn-On Switching Loss				13.5		mJ
$E_{off}$	Turn-Off Switching Loss				6.35		mJ
$t_{d(on)}$	Turn-On Delay Time		$V_{CC}=600\text{V}, I_C=225\text{A}, R_G=2.0\Omega, L_S=20\text{nH}, V_{GE}=-8/+15\text{V}, T_{vj}=125^\circ\text{C}$		157		ns
$t_r$	Rise Time				50		ns
$t_{d(off)}$	Turn-Off Delay Time				349		ns
$t_f$	Fall Time				123		ns
$E_{on}$	Turn-On Switching Loss				16.9		mJ
$E_{off}$	Turn-Off Switching Loss				8.85		mJ
$t_{d(on)}$	Turn-On Delay Time	$V_{CC}=600\text{V}, I_C=225\text{A}, R_G=2.0\Omega, L_S=20\text{nH}, V_{GE}=-8/+15\text{V}, T_{vj}=150^\circ\text{C}$			159		ns
$t_r$	Rise Time				50		ns
$t_{d(off)}$	Turn-Off Delay Time			363		ns	
$t_f$	Fall Time			196		ns	
$E_{on}$	Turn-On Switching Loss				18.1		mJ
$E_{off}$	Turn-Off Switching Loss				9.52		mJ

**D1/D4 Diode Characteristics**  $T_C=25^{\circ}\text{C}$  unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$V_F$	Diode Forward Voltage	$I_F=300\text{A}, V_{GE}=0\text{V}, T_{vj}=25^{\circ}\text{C}$		1.60	2.05	V
		$I_F=300\text{A}, V_{GE}=0\text{V}, T_{vj}=125^{\circ}\text{C}$		1.60		
		$I_F=300\text{A}, V_{GE}=0\text{V}, T_{vj}=150^{\circ}\text{C}$		1.60		
$Q_r$	Recovered Charge	$V_R=600\text{V}, I_F=225\text{A},$ $-di/dt=5350\text{A}/\mu\text{s}, L_S=20\text{nH},$ $V_{GE}=-8\text{V}, T_{vj}=25^{\circ}\text{C}$		20.1		$\mu\text{C}$
$I_{RM}$	Peak Reverse Recovery Current			250		A
$E_{rec}$	Reverse Recovery Energy			6.84		mJ
$Q_r$	Recovered Charge	$V_R=600\text{V}, I_F=225\text{A},$ $-di/dt=5080\text{A}/\mu\text{s}, L_S=20\text{nH},$ $V_{GE}=-8\text{V}, T_{vj}=125^{\circ}\text{C}$		32.5		$\mu\text{C}$
$I_{RM}$	Peak Reverse Recovery Current			277		A
$E_{rec}$	Reverse Recovery Energy			12.5		mJ
$Q_r$	Recovered Charge	$V_R=600\text{V}, I_F=225\text{A},$ $-di/dt=4930\text{A}/\mu\text{s}, L_S=20\text{nH},$ $V_{GE}=-8\text{V}, T_{vj}=150^{\circ}\text{C}$		39.0		$\mu\text{C}$
$I_{RM}$	Peak Reverse Recovery Current			288		A
$E_{rec}$	Reverse Recovery Energy			14.0		mJ

**D2/D3 Diode Characteristics**  $T_C=25^{\circ}\text{C}$  unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$V_F$	Diode Forward Voltage	$I_F=225\text{A}, V_{GE}=0\text{V}, T_{vj}=25^{\circ}\text{C}$		1.60	2.05	V
		$I_F=225\text{A}, V_{GE}=0\text{V}, T_{vj}=125^{\circ}\text{C}$		1.60		
		$I_F=225\text{A}, V_{GE}=0\text{V}, T_{vj}=150^{\circ}\text{C}$		1.60		

**D5/D6 Diode Characteristics**  $T_C=25^\circ\text{C}$  unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit		
$V_F$	Diode Forward Voltage	$I_F=300\text{A}, V_{GE}=0\text{V}, T_{vj}=25^\circ\text{C}$		1.60	2.05	V		
		$I_F=300\text{A}, V_{GE}=0\text{V}, T_{vj}=125^\circ\text{C}$		1.60				
		$I_F=300\text{A}, V_{GE}=0\text{V}, T_{vj}=150^\circ\text{C}$		1.60				
$Q_r$	Recovered Charge	$V_R=600\text{V}, I_F=225\text{A},$ $-di/dt=5050\text{A}/\mu\text{s}, L_S=20\text{nH},$ $V_{GE}=-8\text{V}, T_{vj}=25^\circ\text{C}$		18.6		$\mu\text{C}$		
$I_{RM}$	Peak Reverse Recovery Current			189		A		
$E_{rec}$	Reverse Recovery Energy			5.62		mJ		
$Q_r$	Recovered Charge	$V_R=600\text{V}, I_F=225\text{A},$ $-di/dt=4720\text{A}/\mu\text{s}, L_S=20\text{nH},$ $V_{GE}=-8\text{V}, T_{vj}=125^\circ\text{C}$		34.1		$\mu\text{C}$		
			$I_{RM}$	Peak Reverse Recovery Current		250		A
			$E_{rec}$	Reverse Recovery Energy		11.4		mJ
$Q_r$	Recovered Charge	$V_R=600\text{V}, I_F=225\text{A},$ $-di/dt=4720\text{A}/\mu\text{s}, L_S=20\text{nH},$ $V_{GE}=-8\text{V}, T_{vj}=150^\circ\text{C}$		38.9		$\mu\text{C}$		
			$I_{RM}$	Peak Reverse Recovery Current		265		A
			$E_{rec}$	Reverse Recovery Energy		13.2		mJ

**NTC Characteristics**  $T_C=25^\circ\text{C}$  unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$R_{25}$	Rated Resistance			5.0		$\text{k}\Omega$
$\Delta R/R$	Deviation of $R_{100}$	$T_C=100^\circ\text{C}, R_{100}=493.3\Omega$	-5		5	%
$P_{25}$	Power Dissipation				20.0	mW
$B_{25/50}$	B-value	$R_2=R_{25}\exp[B_{25/50}(1/T_2-1/(298.15\text{K}))]$		3375		K
$B_{25/80}$	B-value	$R_2=R_{25}\exp[B_{25/80}(1/T_2-1/(298.15\text{K}))]$		3411		K
$B_{25/100}$	B-value	$R_2=R_{25}\exp[B_{25/100}(1/T_2-1/(298.15\text{K}))]$		3433		K

**Module Characteristics**  $T_c=25^\circ\text{C}$  unless otherwise noted

Symbol	Parameter	Min.	Typ.	Max.	Unit
$L_{CE}$	Stray Inductance		15		nH
$R_{thJC}$	Junction-to-Case (per T1-T4 IGBT)			0.231	K/W
	Junction-to-Case (per D1/D4 Diode)			0.338	
	Junction-to-Case (per D2/D3 Diode)			0.373	
	Junction-to-Case (per D5/D6 Diode)			0.338	
M	Mounting Torque, Screw:M5	3.0		5.0	N.m
G	Weight of Module		250		g

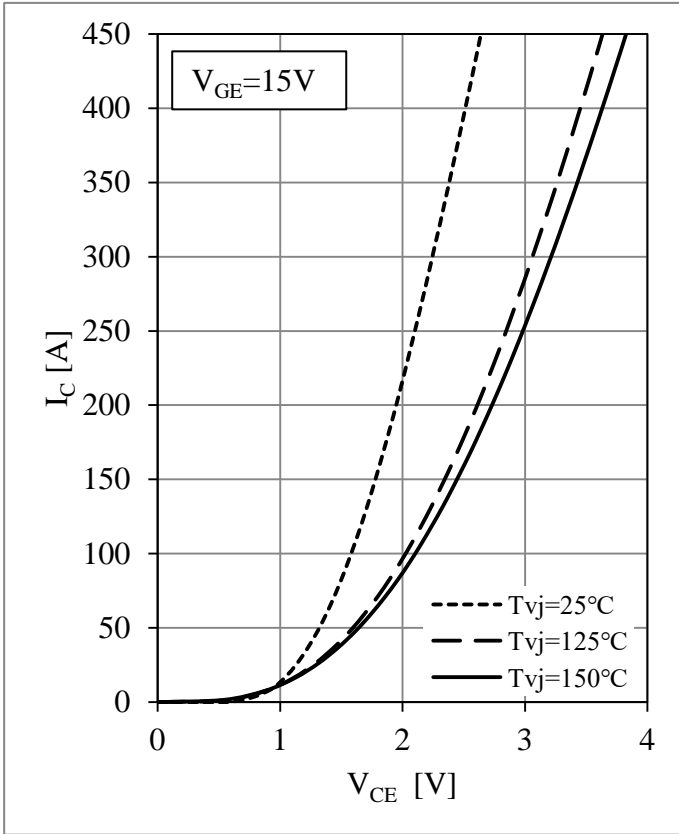


Fig 1. T1/T4 IGBT Output Characteristics

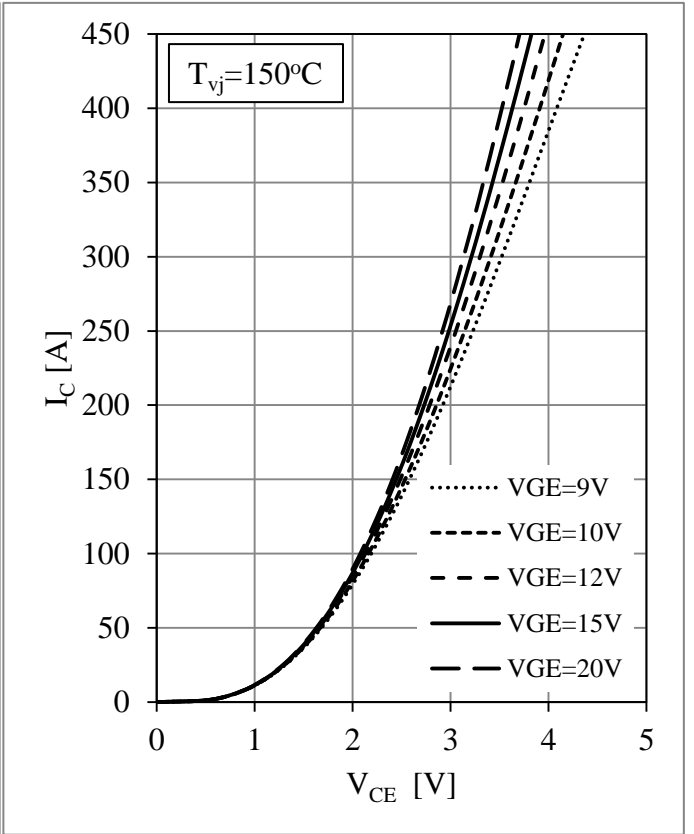


Fig 2. T1/T4 IGBT Output Characteristics

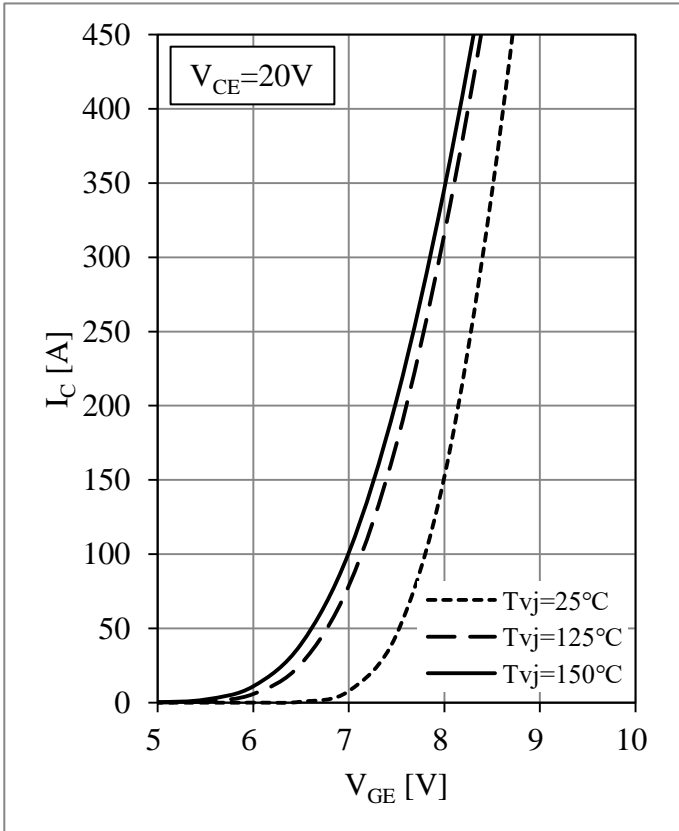


Fig 3. T1/T4 IGBT Transfer Characteristics

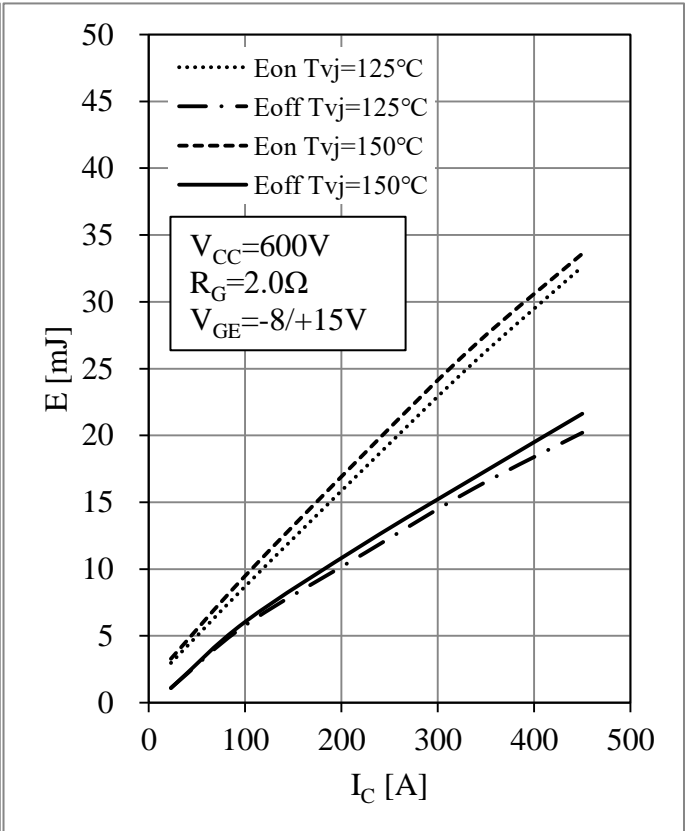


Fig 4. T1/T4 IGBT Switching Loss vs.  $I_C$



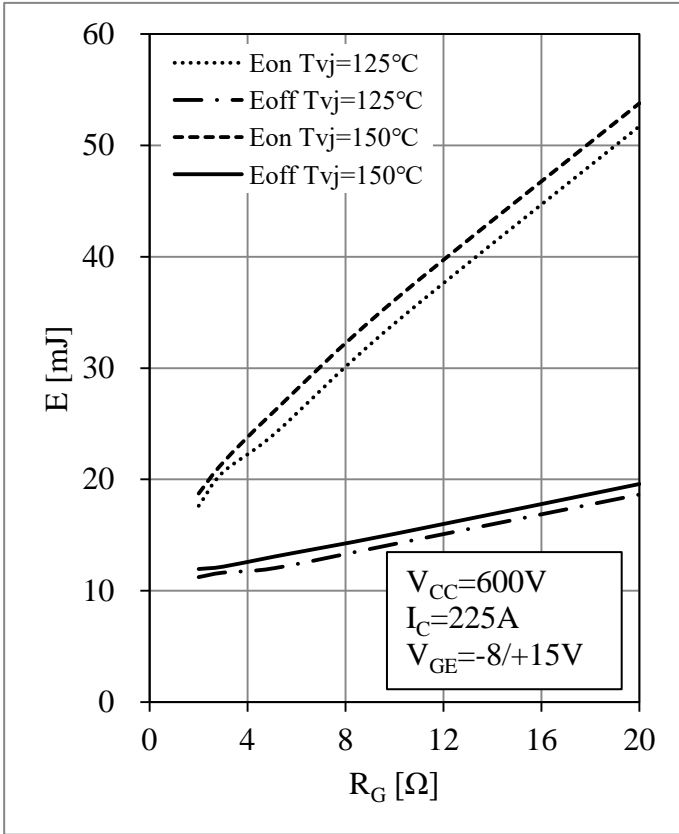


Fig 5. T1/T4 IGBT Switching Loss vs.  $R_G$

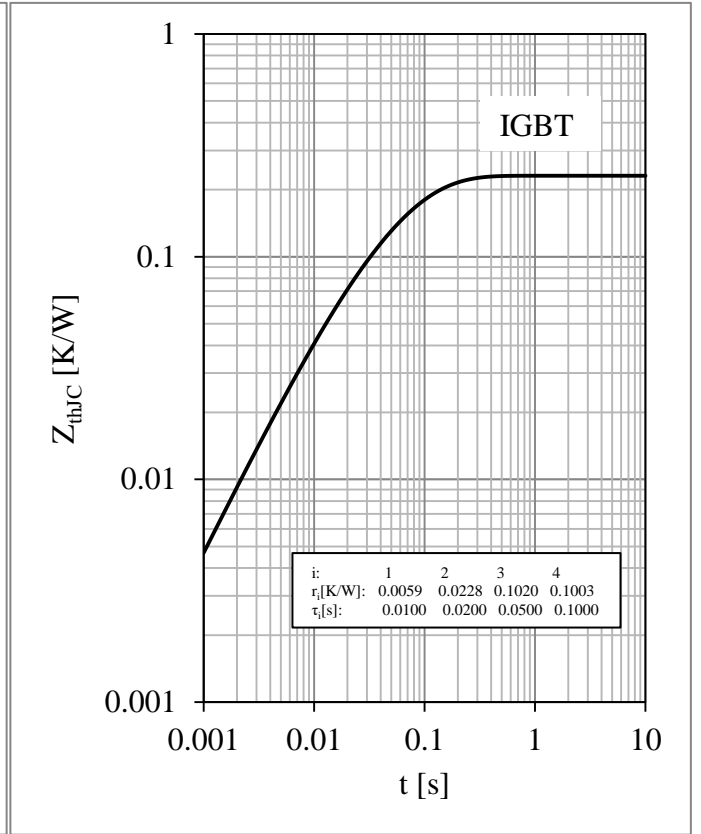


Fig 6. T1/T4 IGBT Transient Thermal Impedance

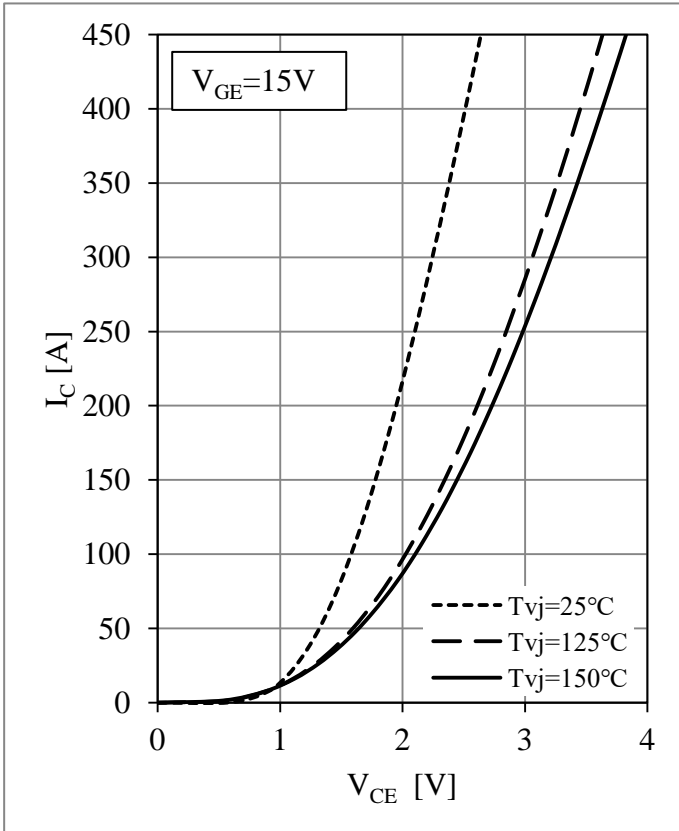


Fig 7. T2/T3 IGBT Output Characteristics

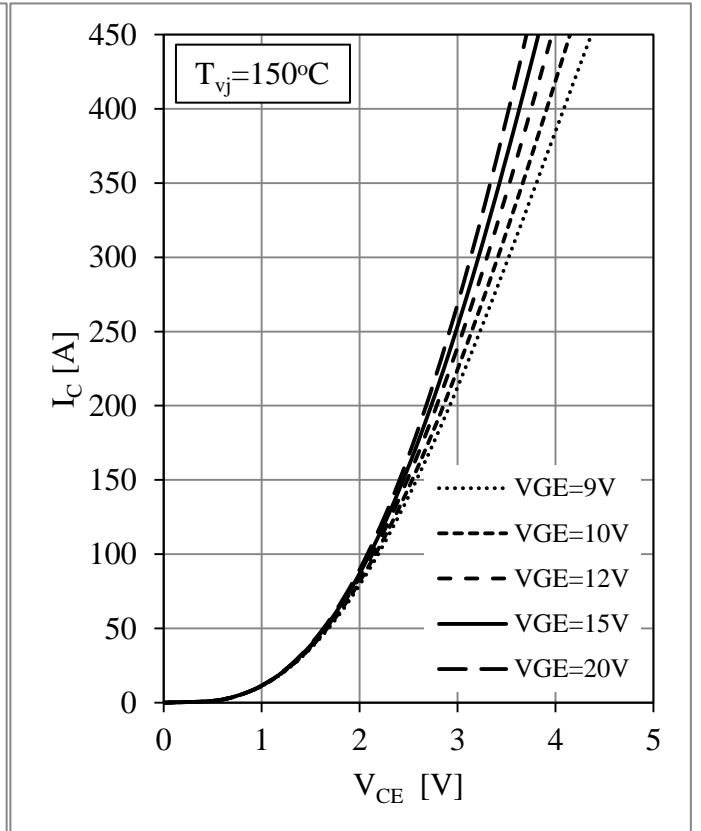


Fig 8. T2/T3 IGBT Output Characteristics

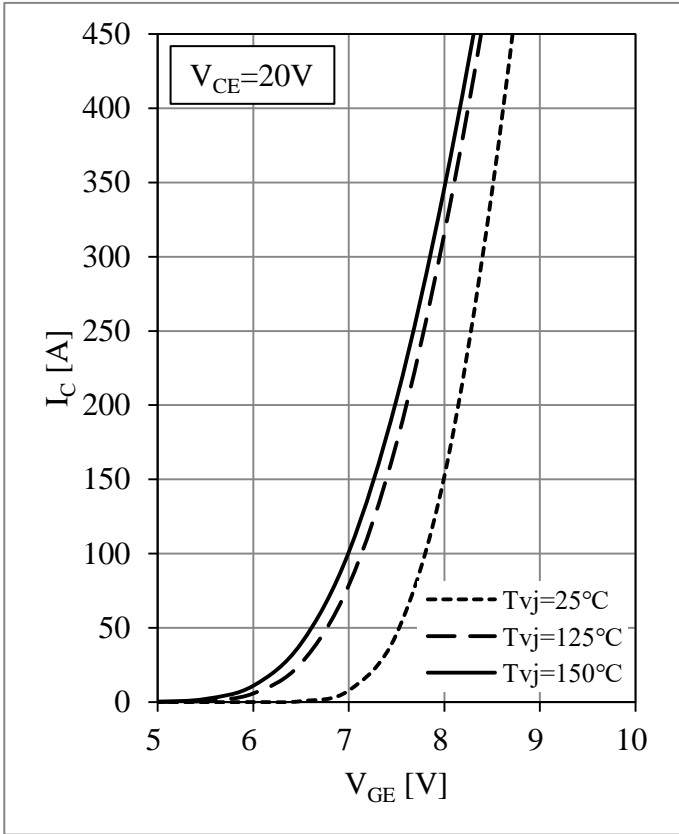


Fig 9. T2/T3 IGBT Transfer Characteristics

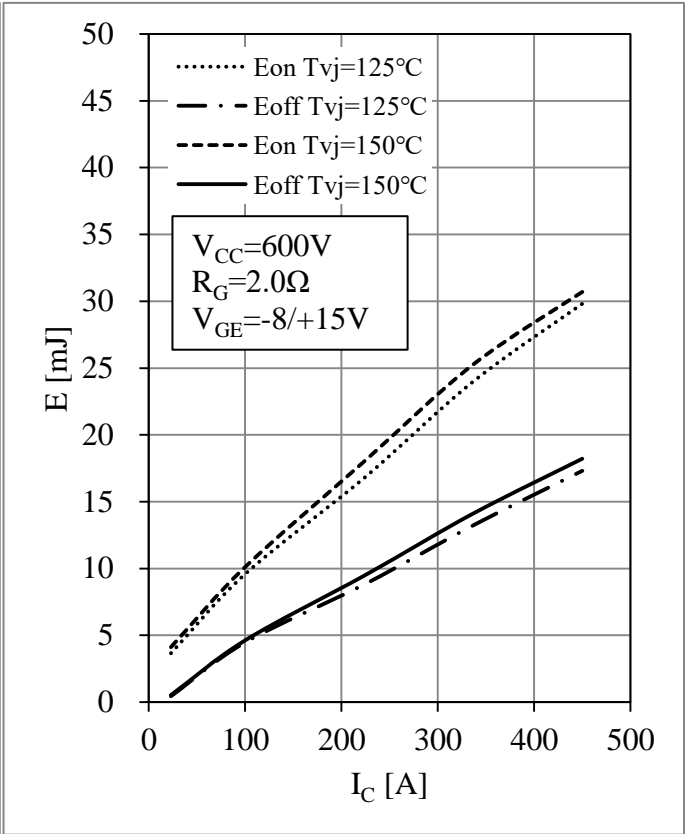


Fig 10. T2/T3 IGBT Switching Loss vs.  $I_c$

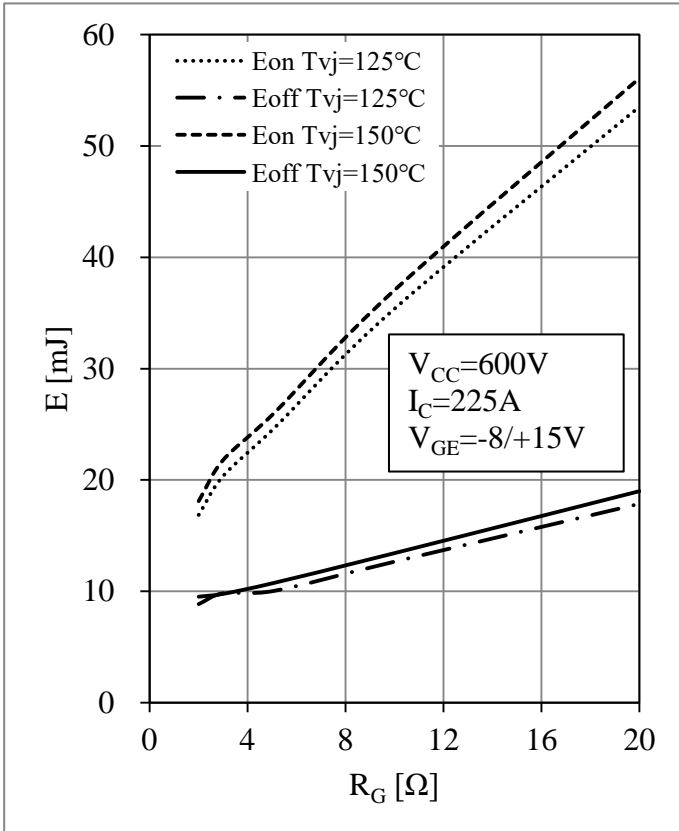


Fig 11. T2/T3 IGBT Switching Loss vs.  $R_G$

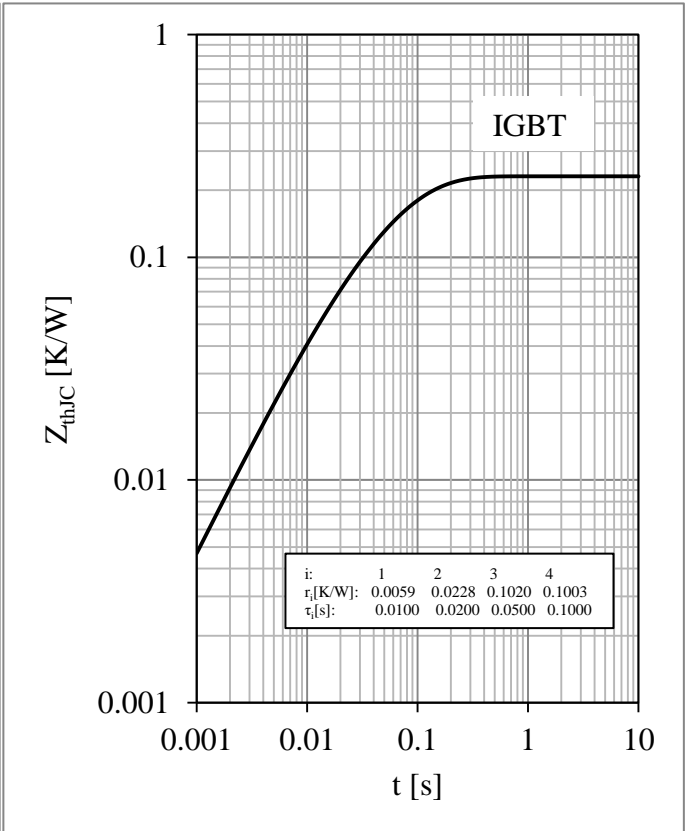


Fig 12. T2/T3 IGBT Transient Thermal Impedance

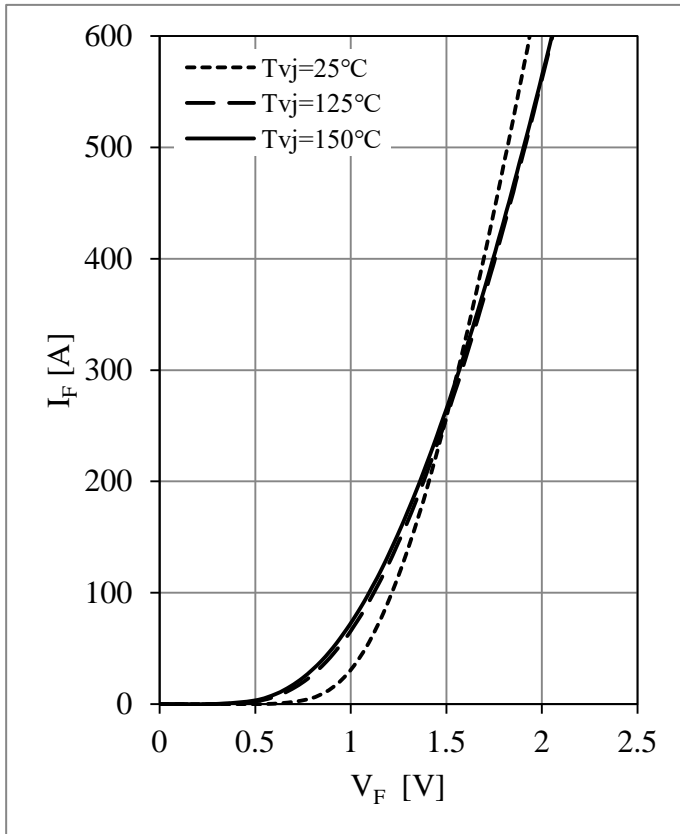


Fig 13. D1/D4 Diode Forward Characteristics

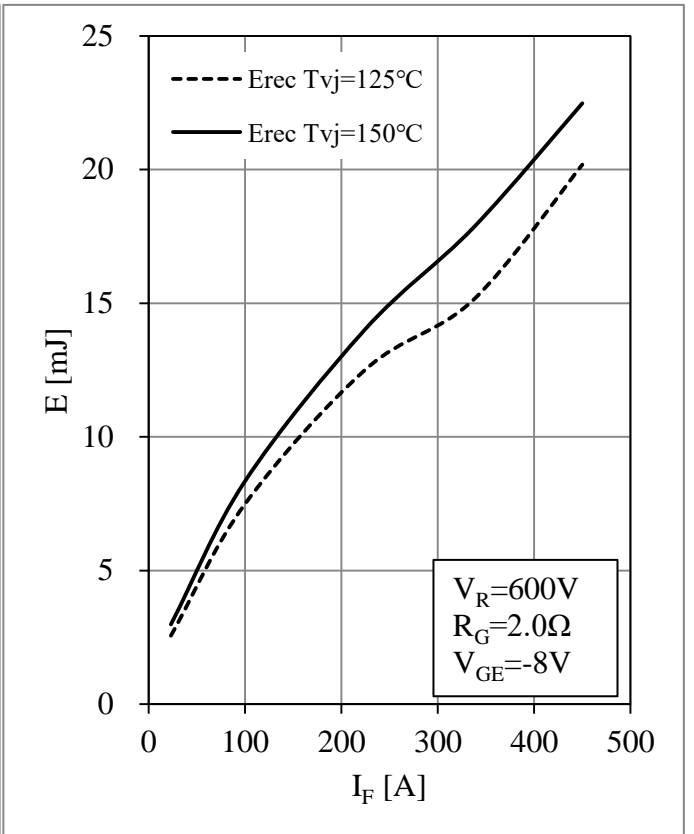


Fig 14. D1/D4 Diode Switching Loss vs.  $I_F$

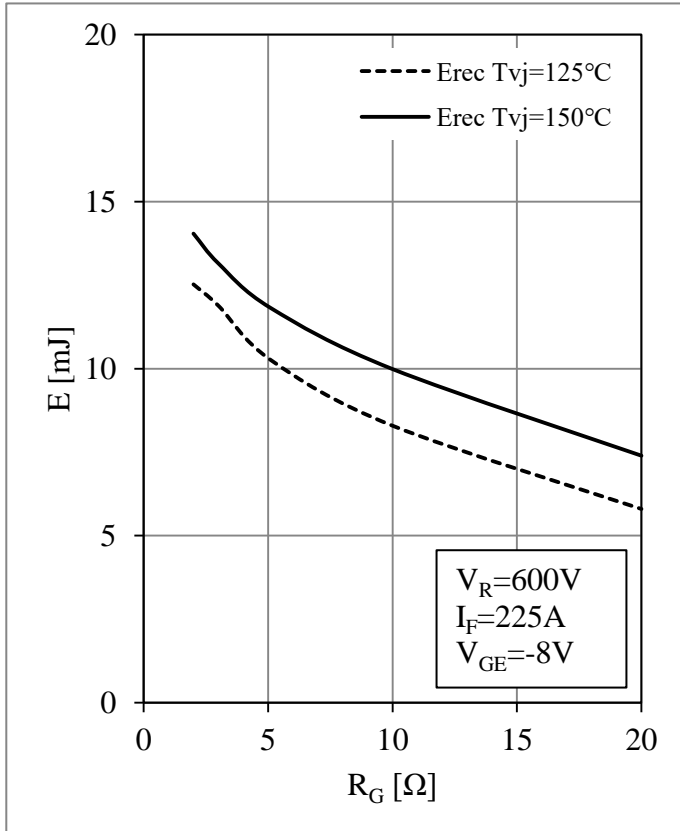


Fig 15. D1/D4 Diode Switching Loss vs.  $R_G$

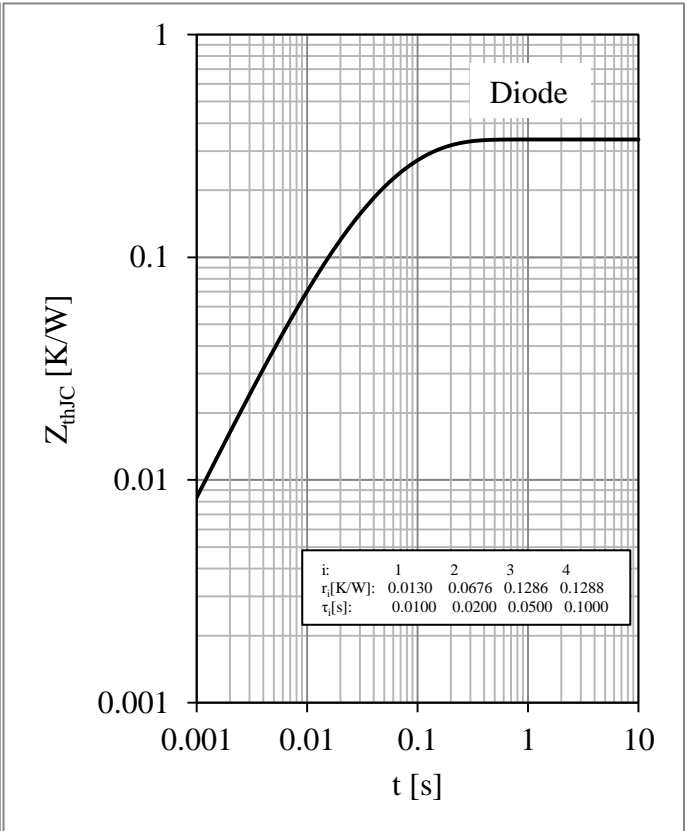


Fig 16. D1/D4 Diode Transient Thermal Impedance

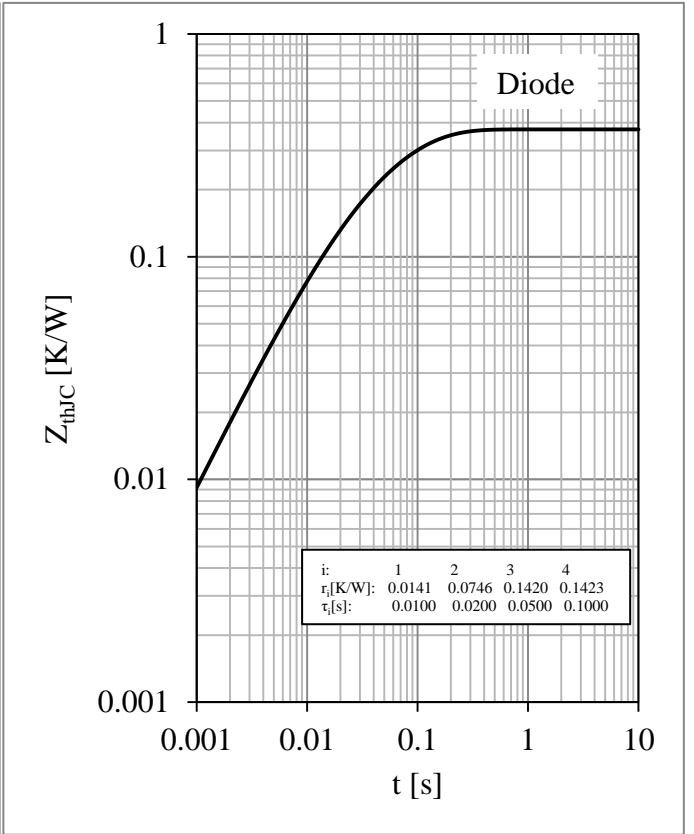
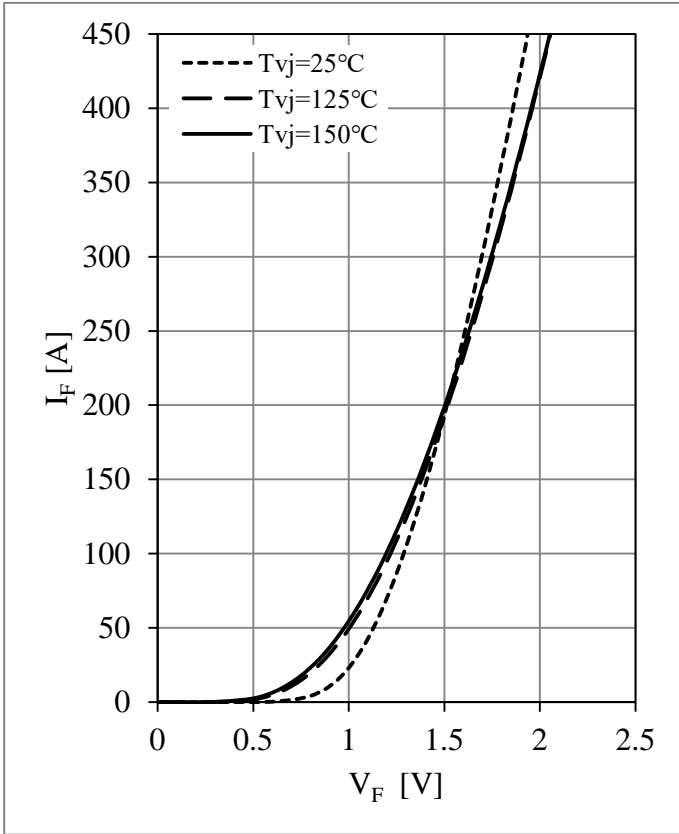


Fig 17. D2/D3 Diode Forward Characteristics

Fig 18. D2/D3 Diode Transient Thermal Impedance

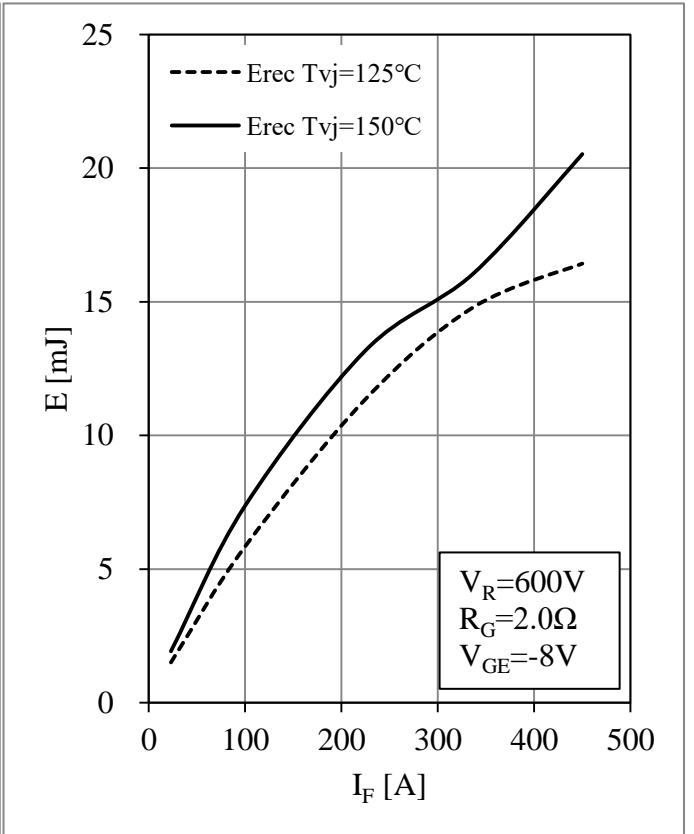
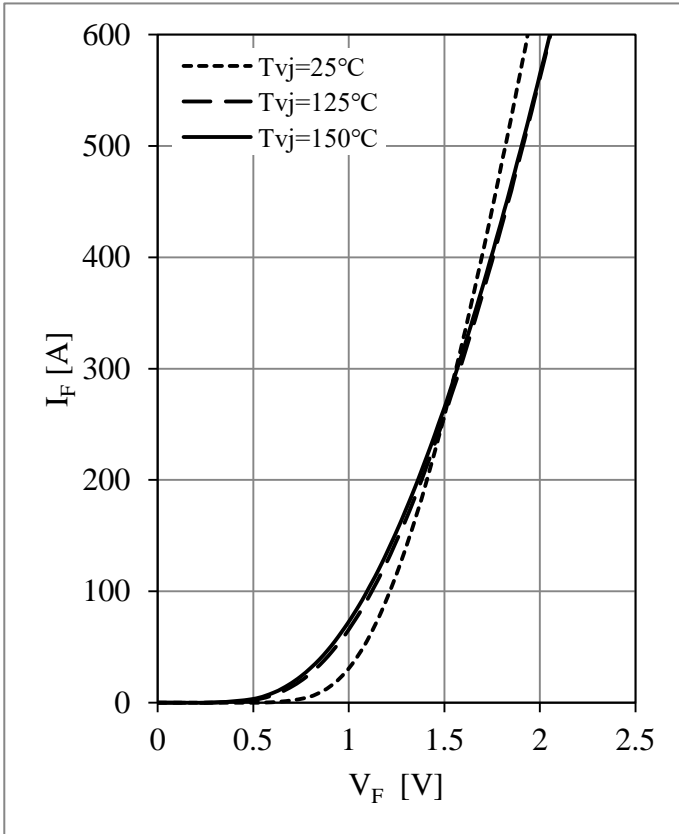


Fig 19. D5/D6 Diode Forward Characteristics

Fig 20. D5/D6 Diode Switching Loss vs.  $I_F$

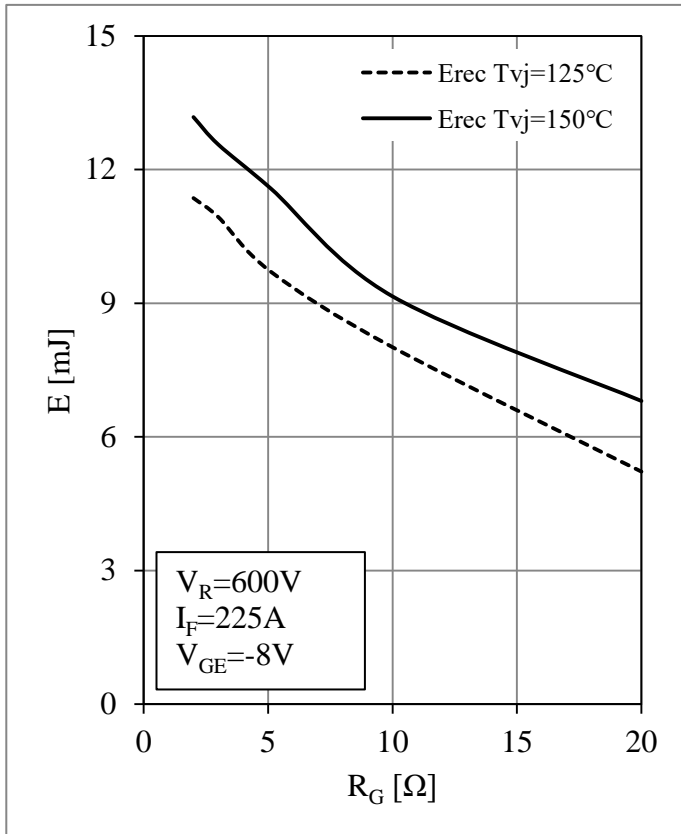


Fig 21. D5/D6 Diode Switching Loss vs.  $R_G$

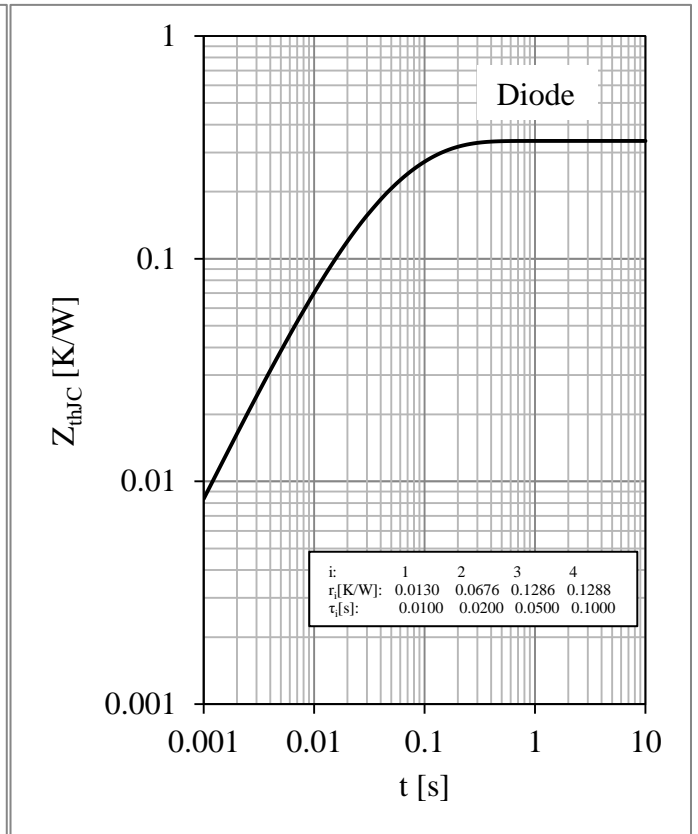


Fig 22. D5/D6 Diode Transient Thermal Impedance

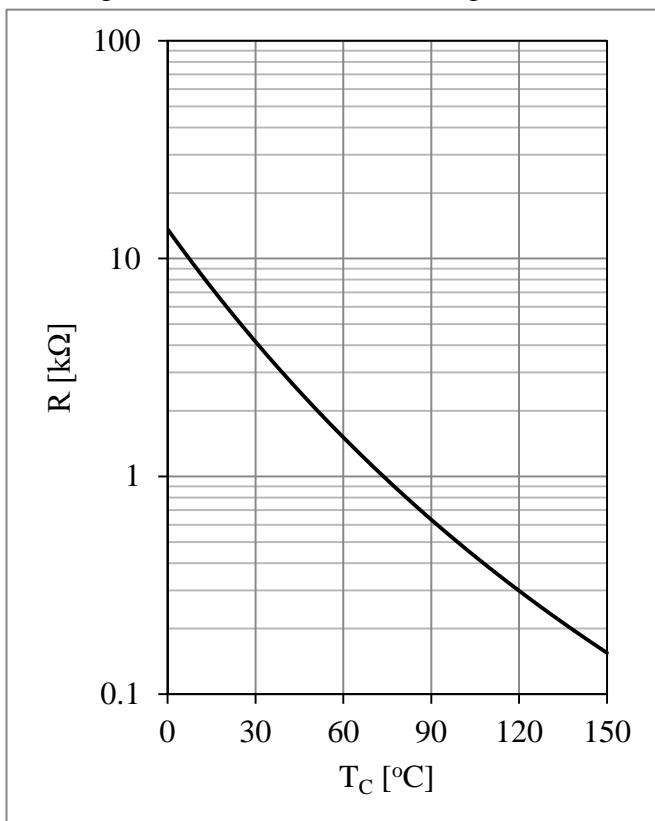
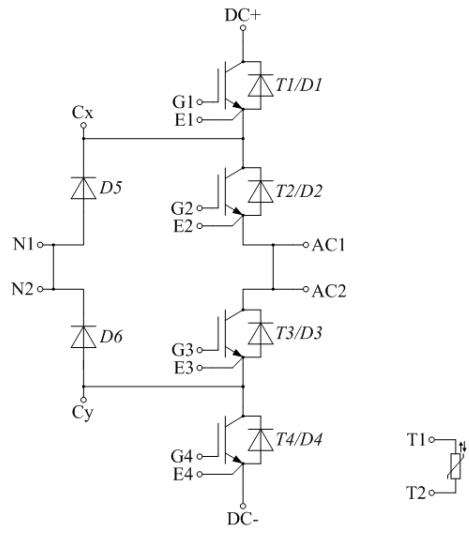


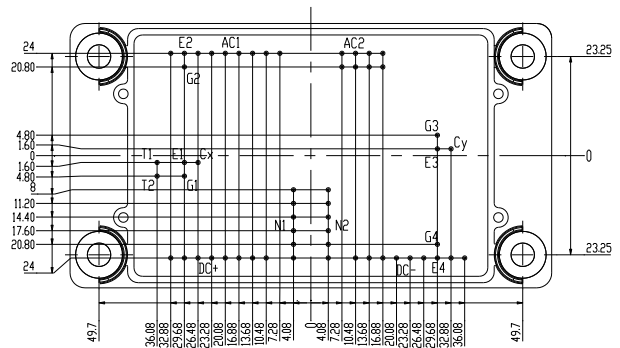
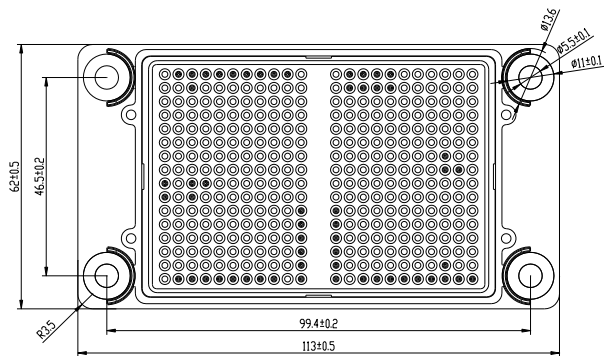
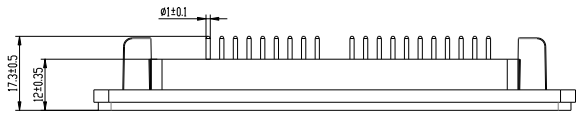
Fig 23. NTC Temperature Characteristic

**Circuit Schematic**



**Package Dimensions**

Dimensions in Millimeters



## Terms and Conditions of Usage

The data contained in this product datasheet is exclusively intended for technically trained staff. you and your technical departments will have to evaluate the suitability of the product for the intended application and the completeness of the product data with respect to such application.

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